

Bits From Photons: Oversampled Binary Image Acquisition

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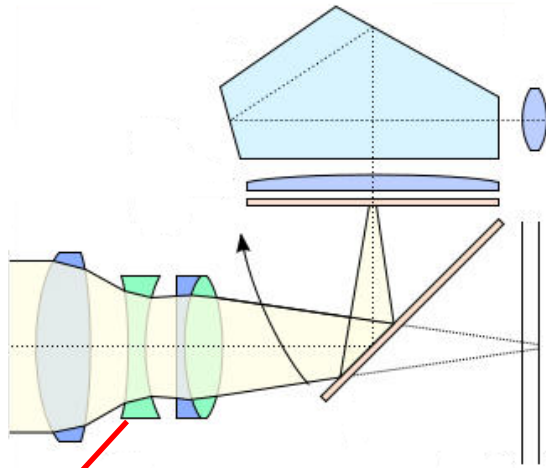
Outline

- Motivation
- Binary imaging
- Binary noisy imaging
- Threshold and optimal pattern design
- Generalized piecewise-constant model
- Conclusions and future research

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Traditional camera



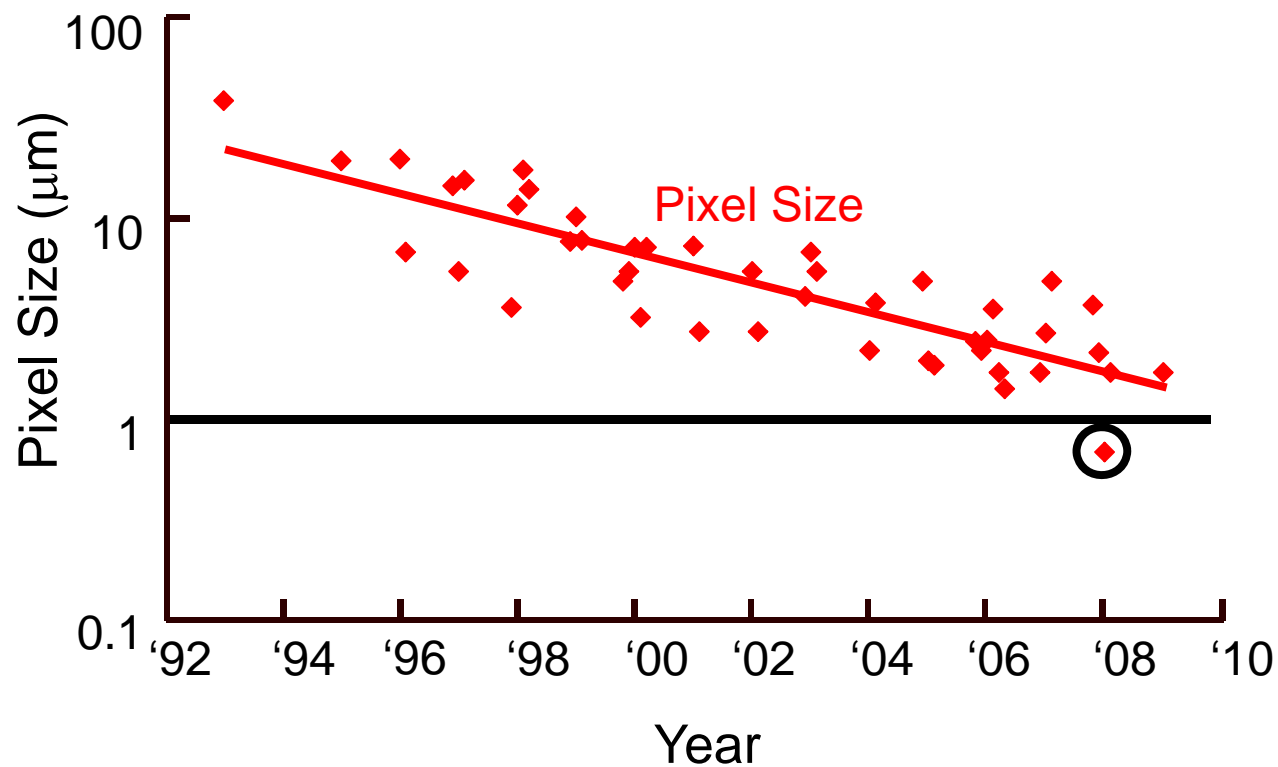
Optical Lens

Resolution



CMOS sensor

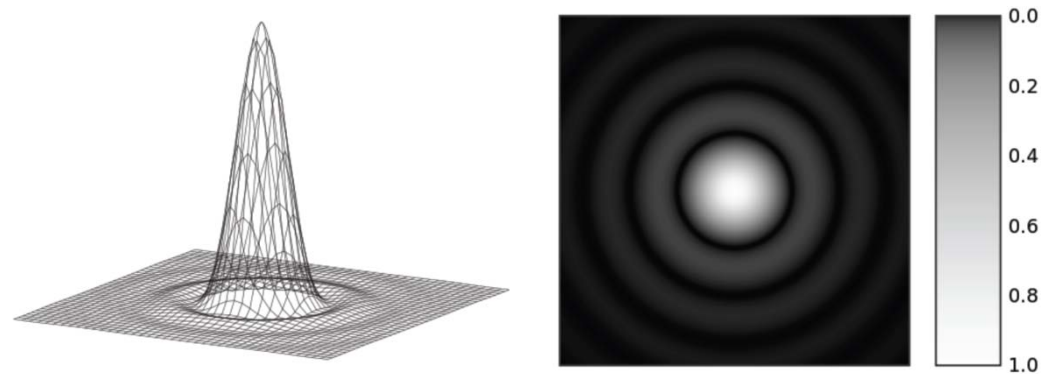
The evolution of pixel size in CMOS sensor



courtesy of Theuwissen [Theuwissen'08]

Do we need small pixels (1/2)

Shape of Airy disc on the sensor plane



Rayleigh Criterion: the minimum spatial resolution

$$\Delta l = 1.22 \lambda F\#$$

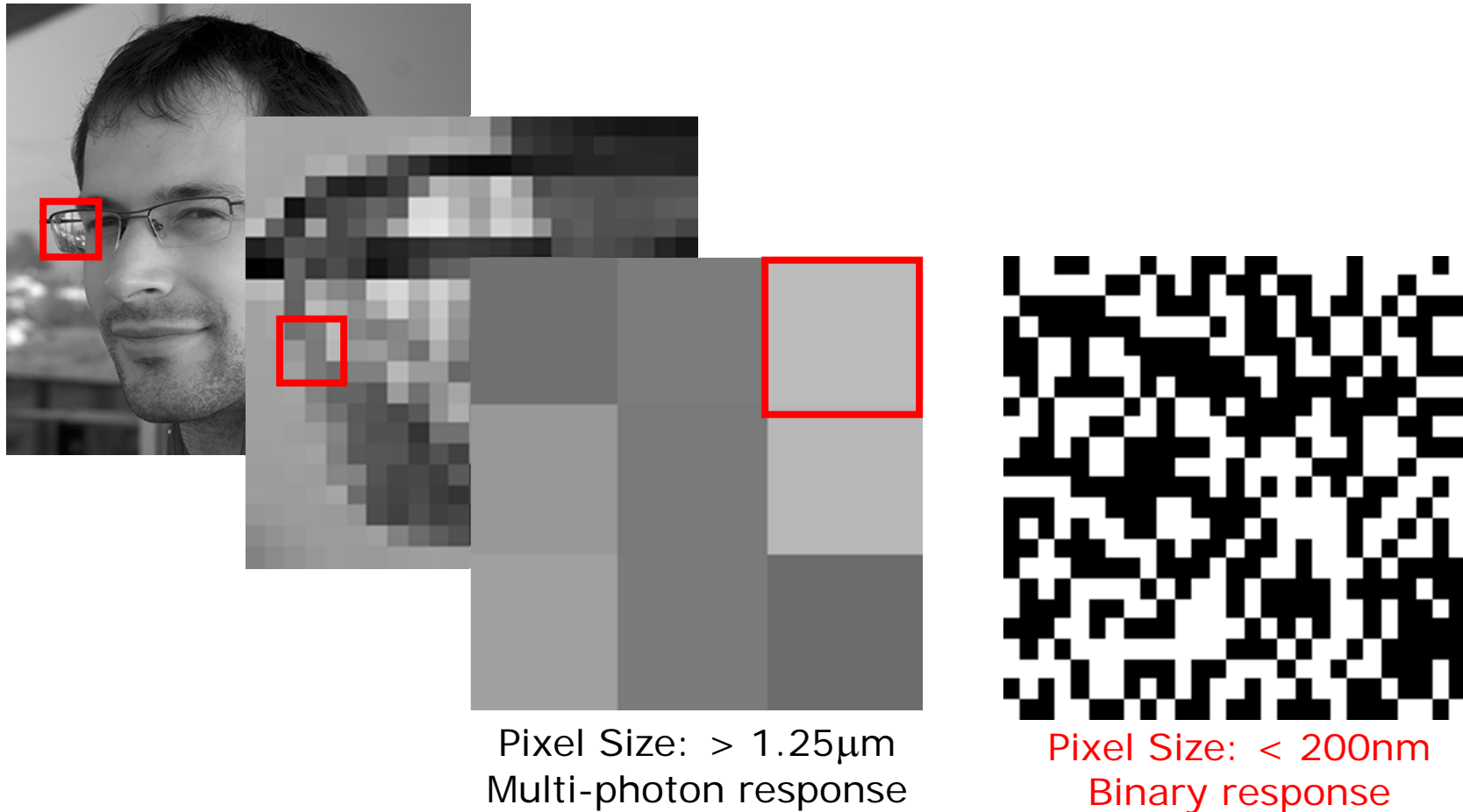
Example: $\lambda = 500nm$, $F\# = 8 \Rightarrow \Delta l \approx 5\mu m$

Do we need small pixels (2/2)

- Image sensor design
 - ~~High resolution~~
 - High sensitivity
 - Low noise
 - High dynamic range
- Small pixel
 - Low full well capacity
 - Low SNR
 - Low dynamic range
 - **Oversampling device**
- Similar to
 - Film (one-bit pixel)
 - Sigma-delta modulator (one-bit quantizer)

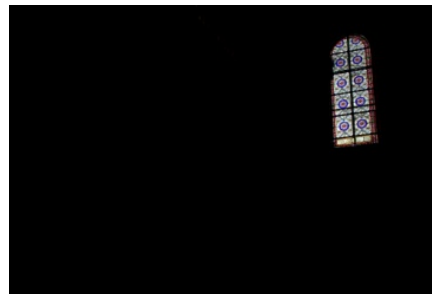
Oversampled binary image sensor

digital film [Fossum'05], gigavision camera [Sbaiz'09]



High dynamic range imaging

Binary sensors with **large oversampling factors** achieve higher dynamic range than conventional sensors



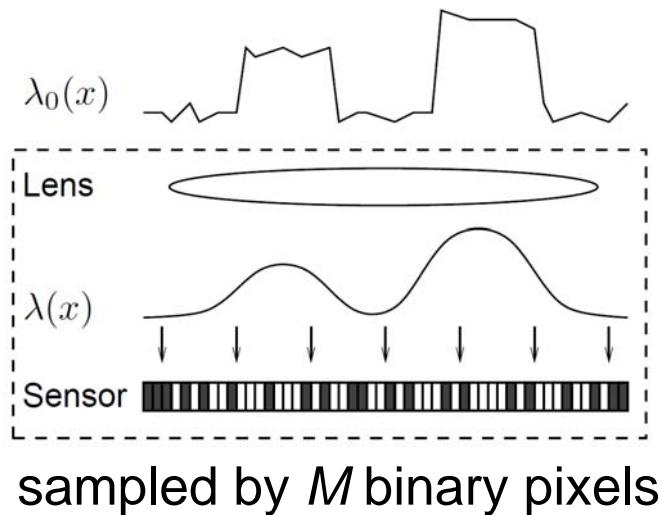
Conventional sensor:
multiple exposures

Binary sensor:
single exposure

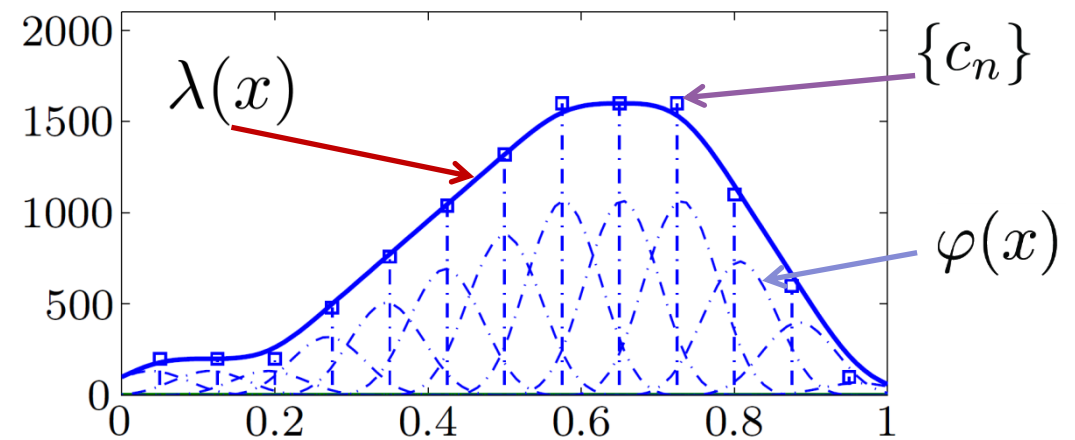
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Imaging model



Light intensity field



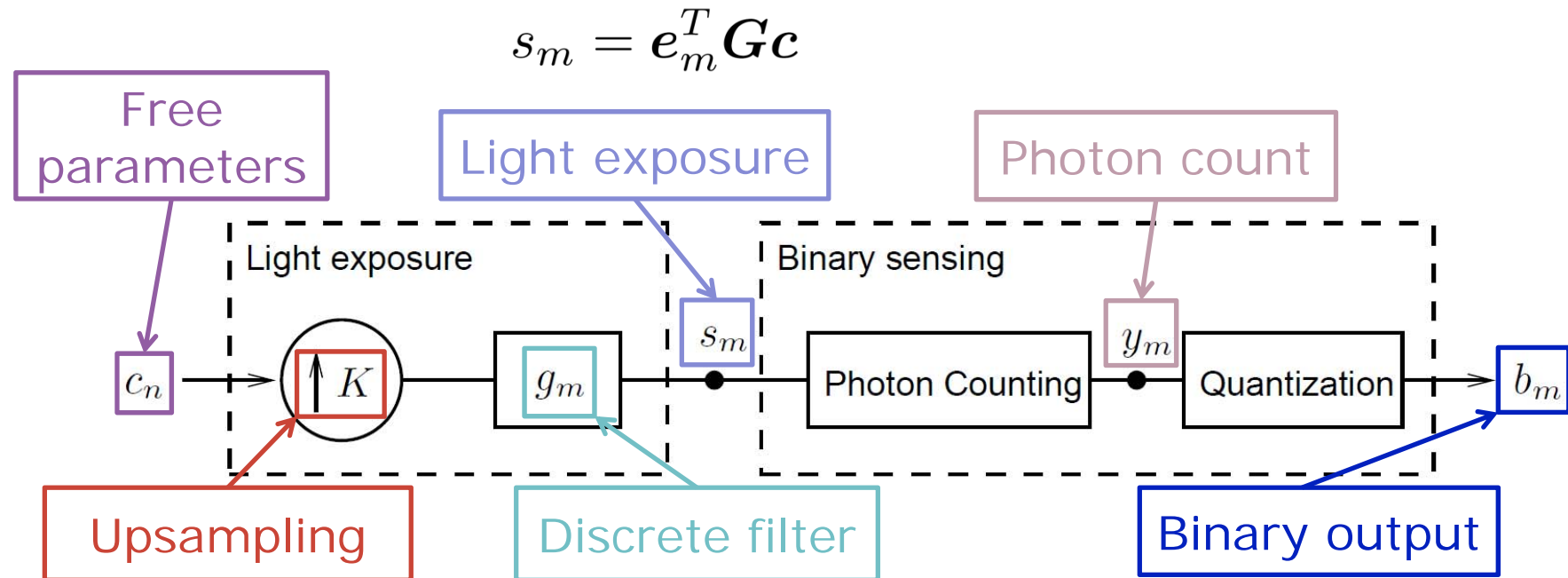
The diffraction-limited light intensity field is modeled as

$$\lambda(x) = \frac{N}{\tau} \sum_{n=0}^{N-1} c_n \varphi\left(\frac{x}{N} - n\right)$$

The equation is annotated with boxes and arrows:

- A purple box labeled "Free parameters" points to the coefficient c_n .
- A teal box labeled "Degrees of freedom" points to the term $\frac{x}{N}$.
- A purple box labeled "Interpolation kernel" points to the function φ .

Signal processing model

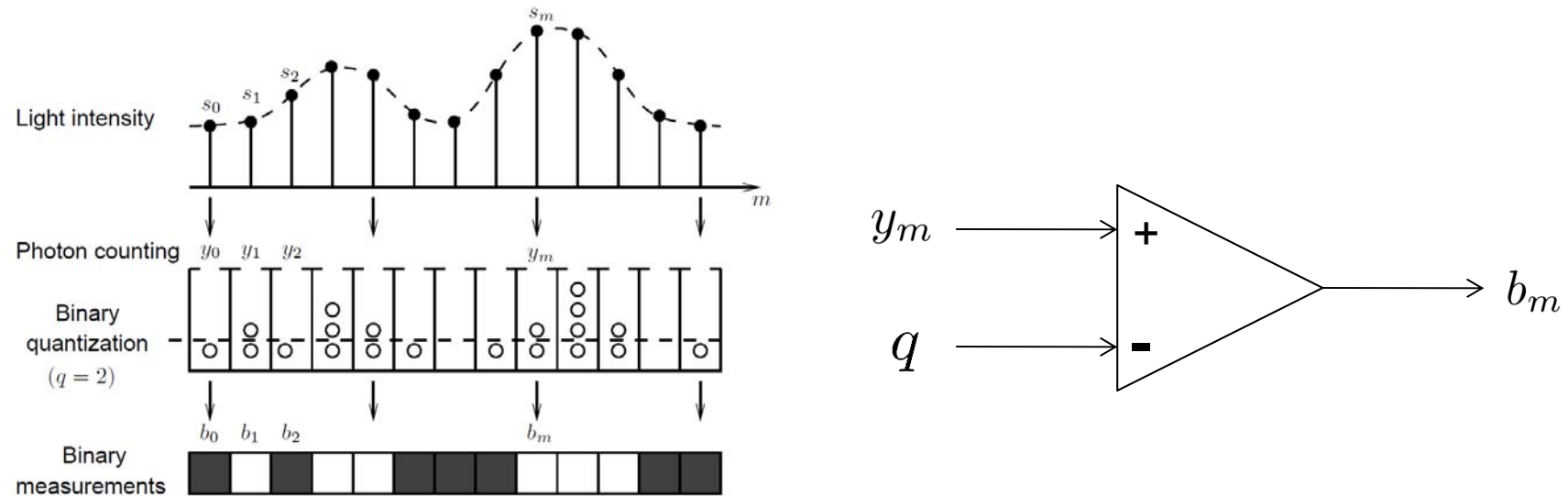


Spatial oversampling factor $K \stackrel{def}{=} \frac{M}{N}$

M : the number of binary pixels

N : the degrees of freedom of the light intensity field

Mathematical model of binary pixel



Photon count y_m : Poisson distribution

$$\mathbb{P}(Y_m = y_m; s_m) = \frac{s_m^{y_m} e^{-s_m}}{y_m!}, \quad \text{for } y_m \in \mathbb{Z}^+ \cup \{0\}$$

Binary output b_m : Bernoulli distribution

$$\mathbb{P}(b_m = 0; s_m) = \sum_{k=0}^{q-1} \frac{s_m^k}{k!} e^{-s_m}$$

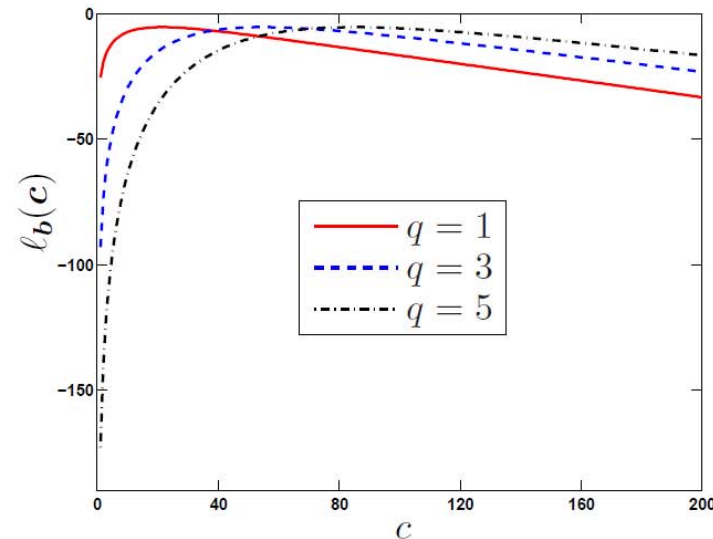
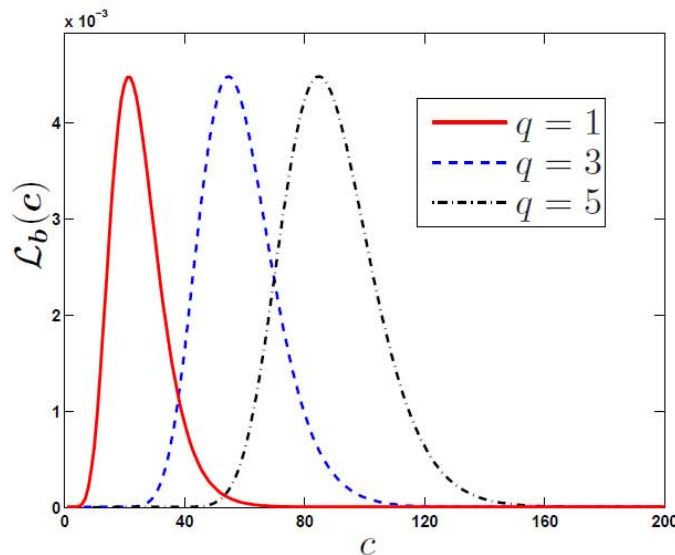
Reconstruction using maximum likelihood estimator

Likelihood function: $\mathcal{L}_b(\mathbf{c}) \stackrel{\text{def}}{=} \prod_{m=0}^{M-1} \mathbb{P}(B_m = b_m; s_m) = \prod_{m=0}^{M-1} \mathbb{P}(B_m = b_m; \mathbf{e}_m^T \mathbf{G} \mathbf{c})$

Log-likelihood function: $\ell_b(\mathbf{c}) \stackrel{\text{def}}{=} \log \mathcal{L}_b(\mathbf{c})$

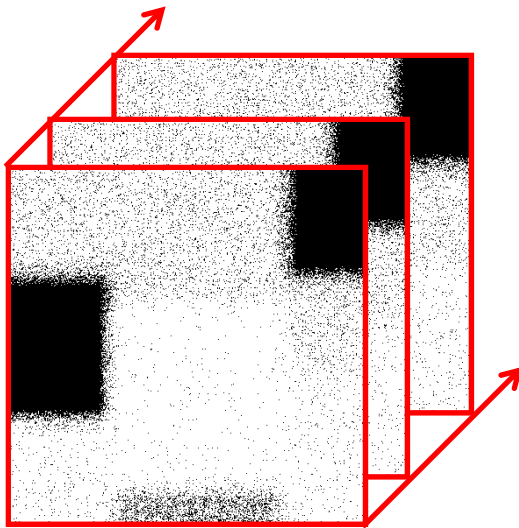
Maximum likelihood estimator: $\hat{\mathbf{c}}_{\text{ML}}(\mathbf{b}) \stackrel{\text{def}}{=} \arg \max_{\mathbf{c} \in [0, S]^N} \mathcal{L}_b(\mathbf{c}) = \arg \max_{\mathbf{c} \in [0, S]^N} \ell_b(\mathbf{c})$

Theorem: The log-likelihood function is **concave**.



Extension: multiple exposures

- Temporal oversampling
- Equivalent to spatial oversampling, using box functions
- Log-likelihood function is concave



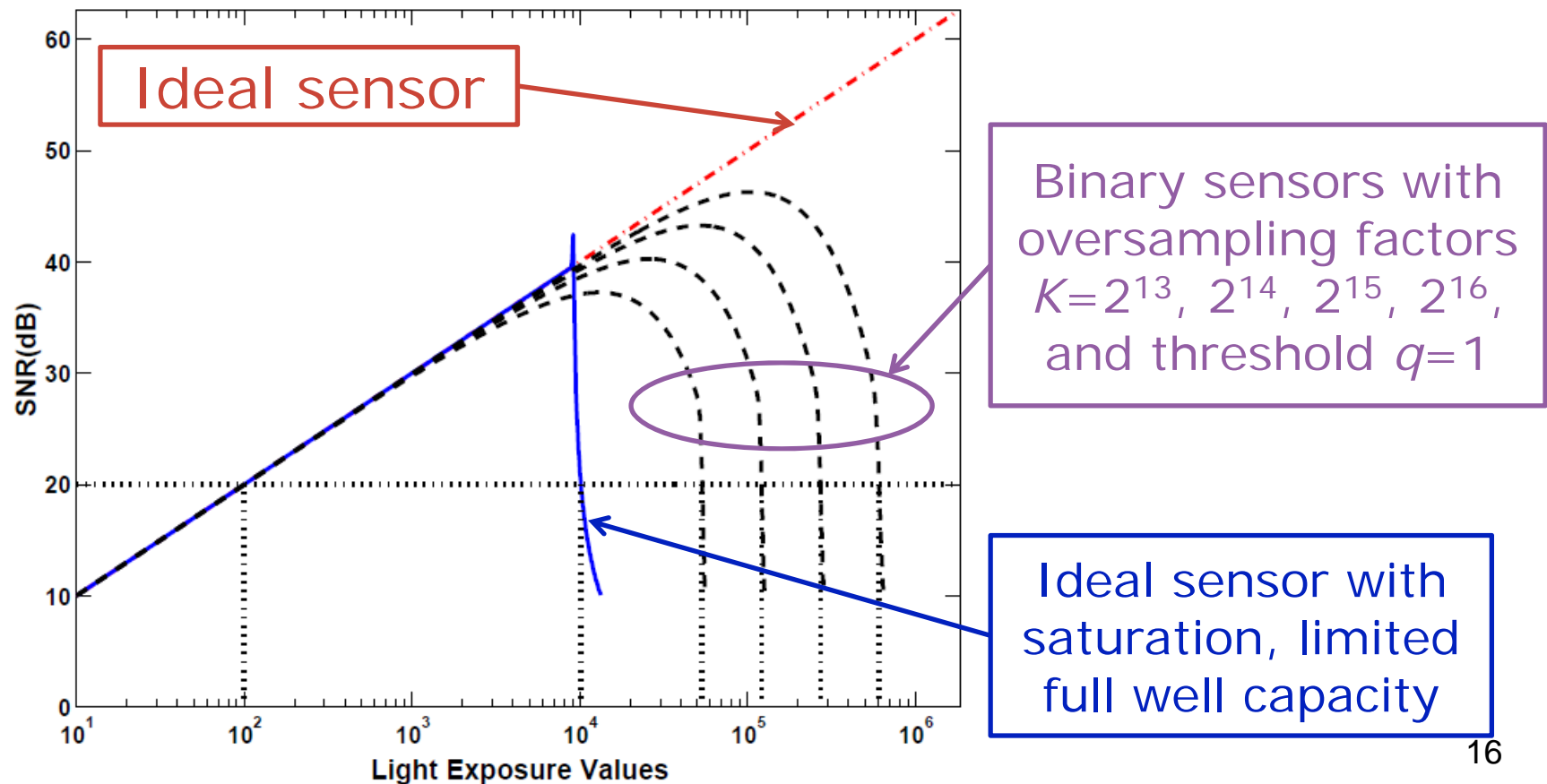
Exposure time for each frame τ/J

Total exposure time is τ

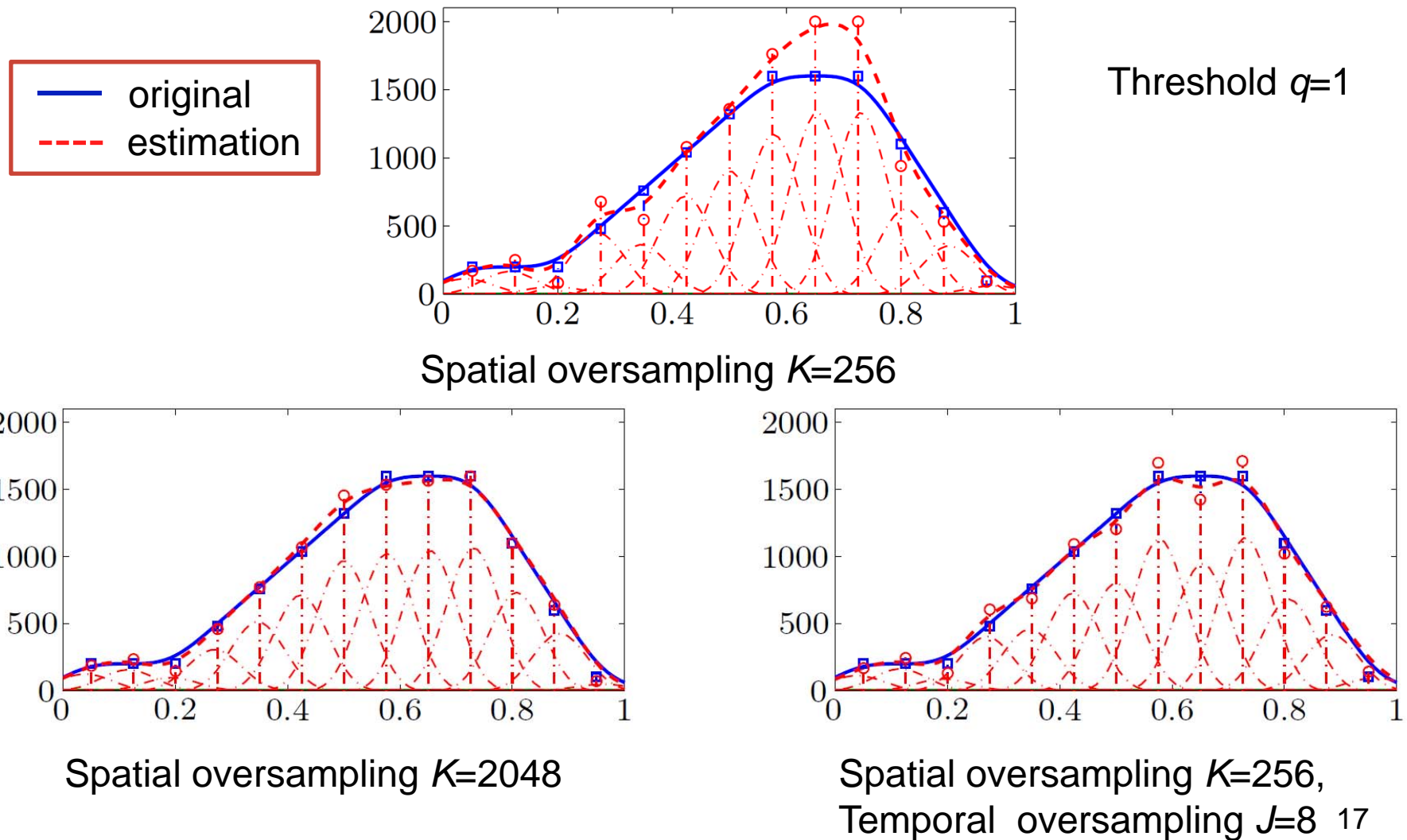
J binary images

Comparison with a conventional sensor

$$\text{SNR} = 10 \log_{10} \frac{c^2}{\mathbb{E}[(\hat{c} - c)^2]}$$



Numerical results: 1-D signals



Numerical results: 2-D images



Threshold: $q=1$

Spatial oversampling: 32×32

Temporal oversampling: 256

Experimental results: real sensor

Single-photon avalanche diode (SPAD) camera



Resolution: 32×32

Pixel value: binary

Sensitivity: single photon

Experimental results: real sensor



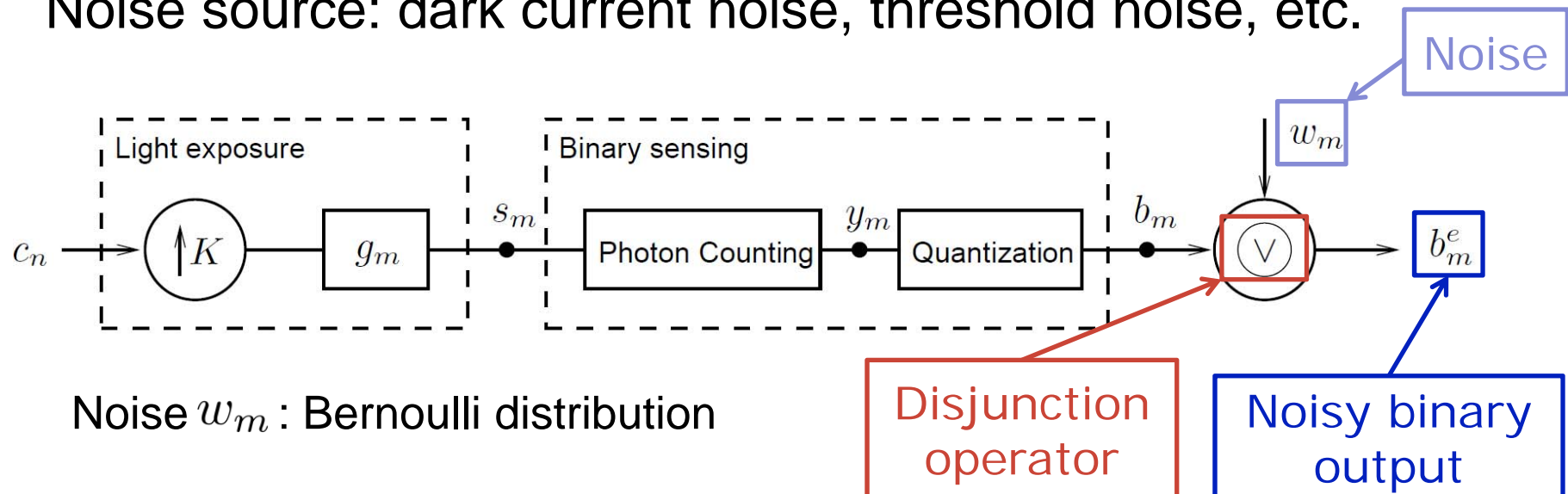
Resolution: 32×32, total images: 4096

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Signal processing model: noisy case

Noise source: dark current noise, threshold noise, etc.



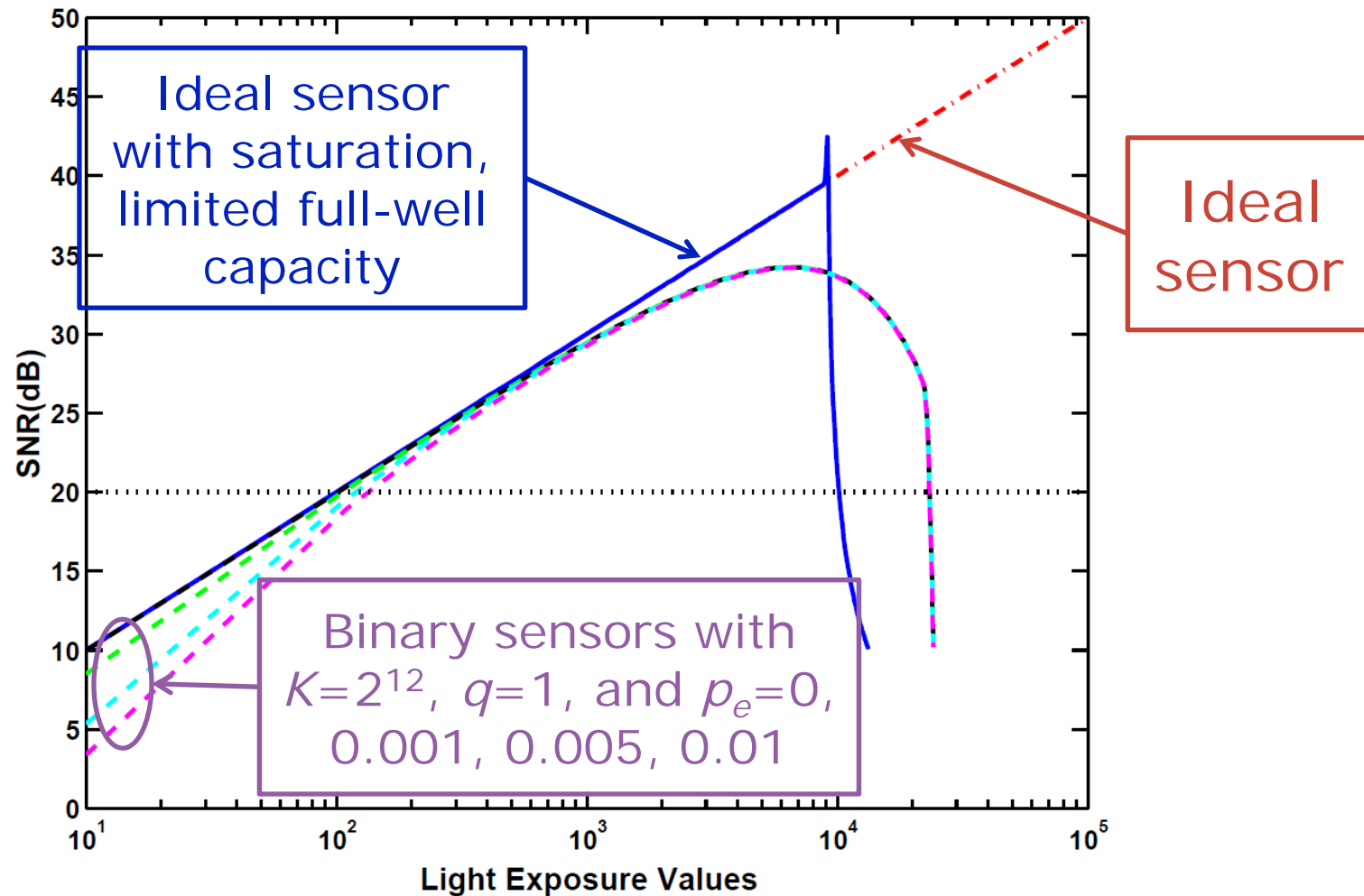
Noise w_m : Bernoulli distribution

$$\mathbb{P}(w_m = 1; p_e) = p_e \quad (\text{noise rate})$$

Noisy binary output: $b_m^e \stackrel{\text{def}}{=} b_m \vee w_m$, Bernoulli distribution

$$\mathbb{P}(b_m^e = 0; s_m, p_e) = (1 - p_e) \sum_{k=0}^{q-1} \frac{s_m^k}{k!} e^{-s_m}$$

Influence of noise



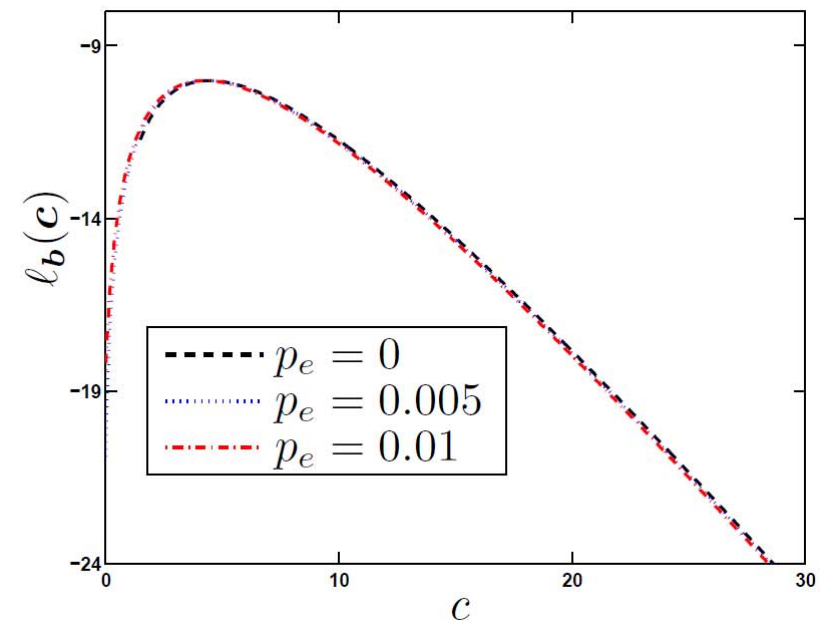
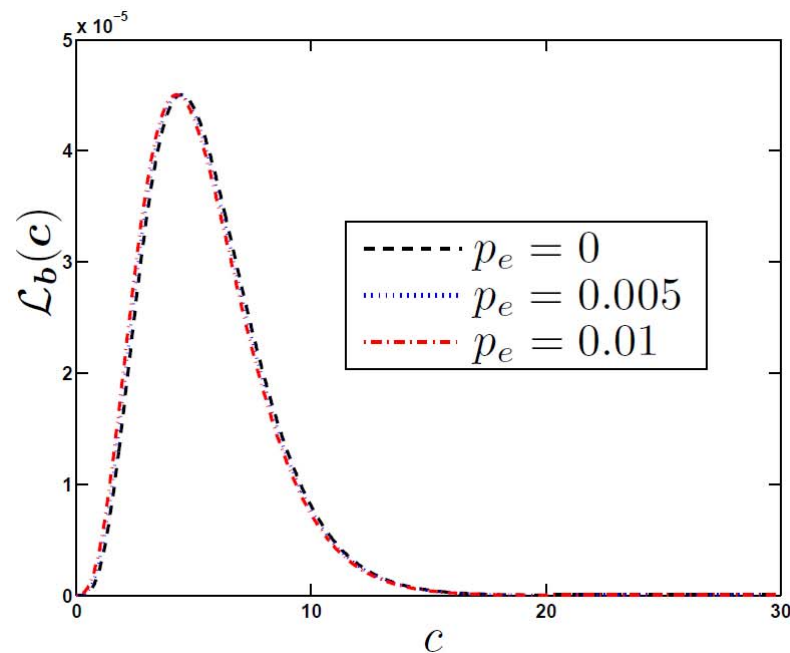
Robust to noise for large light exposure values

Reconstruction using MLE (1/3)

Maximum likelihood estimator

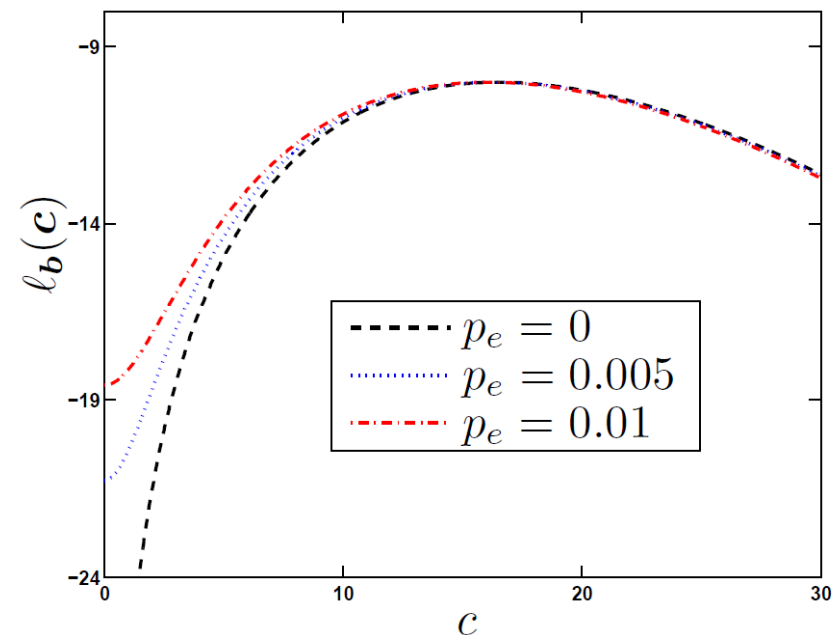
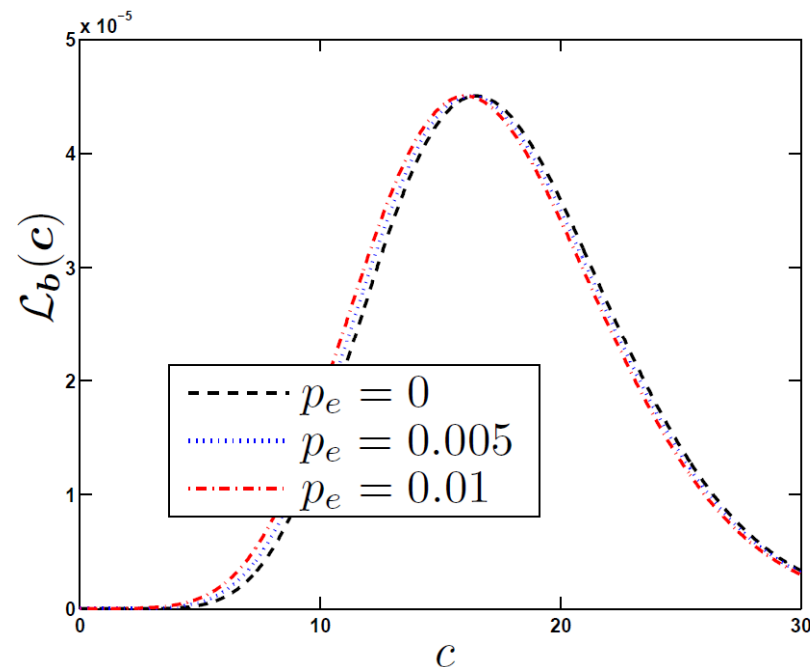
$$\hat{\mathbf{c}}_{\text{ML}}(\mathbf{b}^e) \stackrel{\text{def}}{=} \arg \max_{\mathbf{c} \in [0, S]^N} \mathcal{L}_{\mathbf{b}}^e(\mathbf{c}) = \arg \max_{\mathbf{c} \in [0, S]^N} \ell_{\mathbf{b}}^e(\mathbf{c})$$

Theorem: constant light intensity field, and threshold $q=1$, the log-likelihood function is **concave**.



Reconstruction using MLE (2/3)

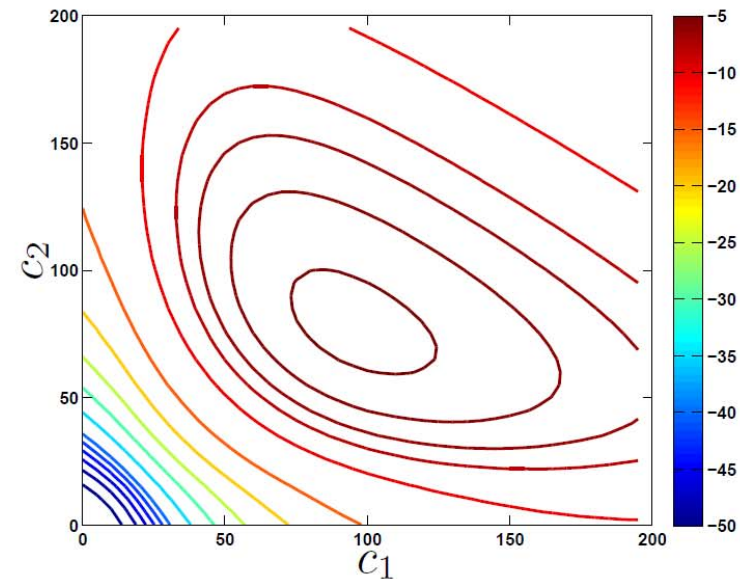
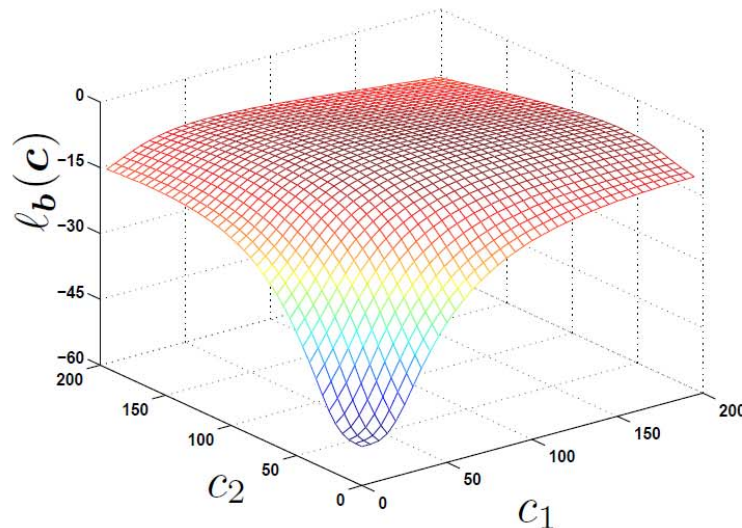
Theorem: constant light intensity field, arbitrary q , both the likelihood function and log-likelihood function are **strictly pseudoconcave**.



Piecewise-constant model, **optimal solution** can be achieved.

Reconstruction using MLE (3/3)

Log-likelihood function for general linear model

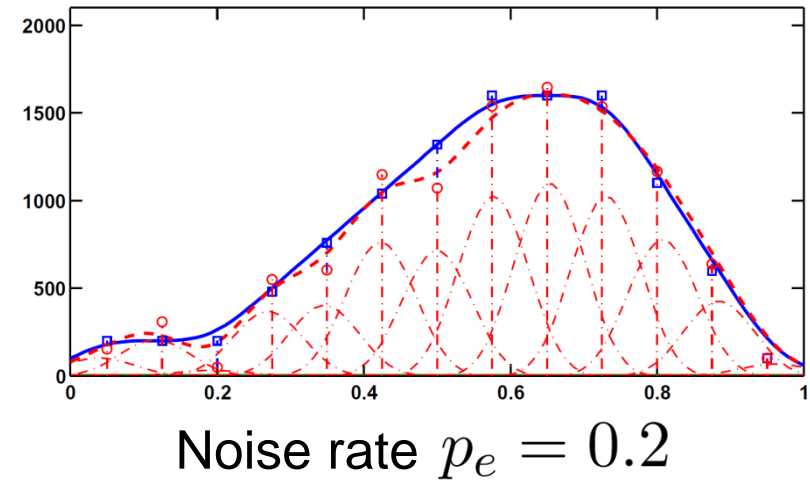
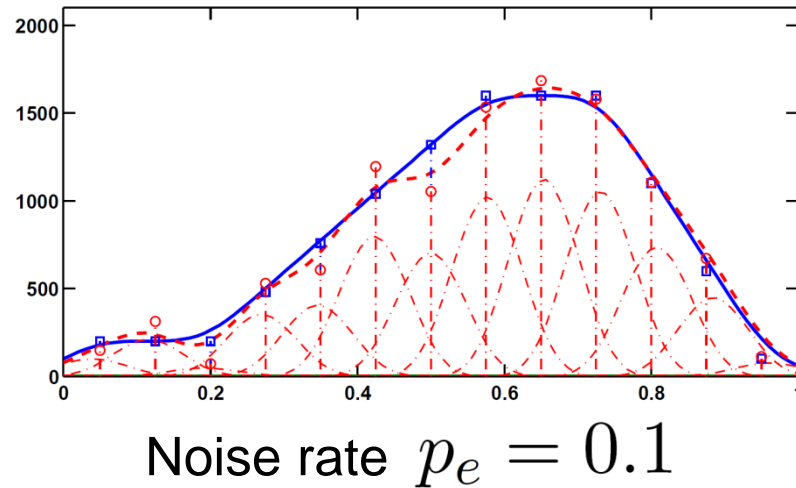
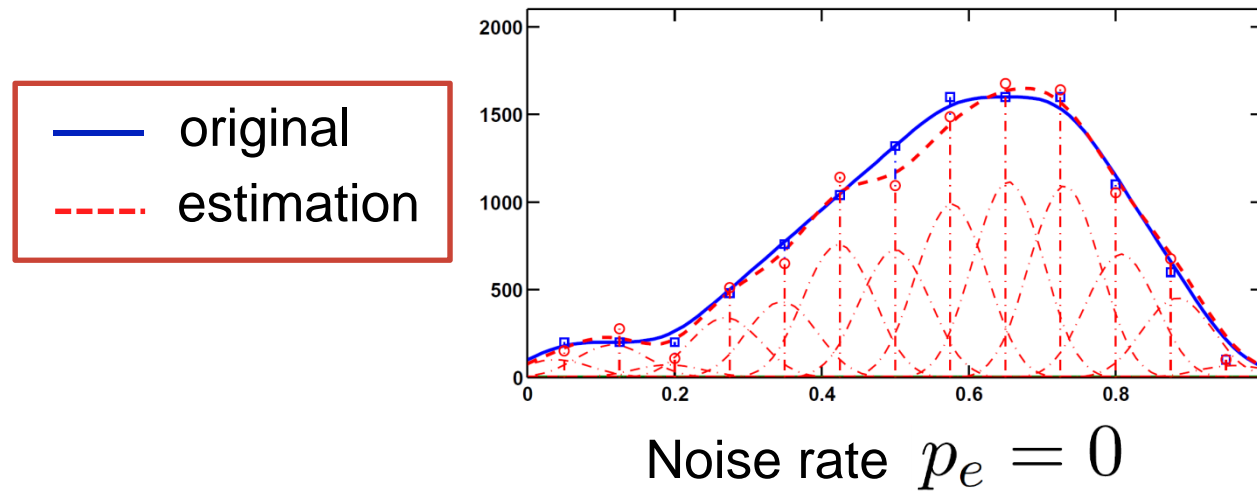


Not even quasi-concave, **no guarantee for the optimal solution**

Reconstruction algorithm

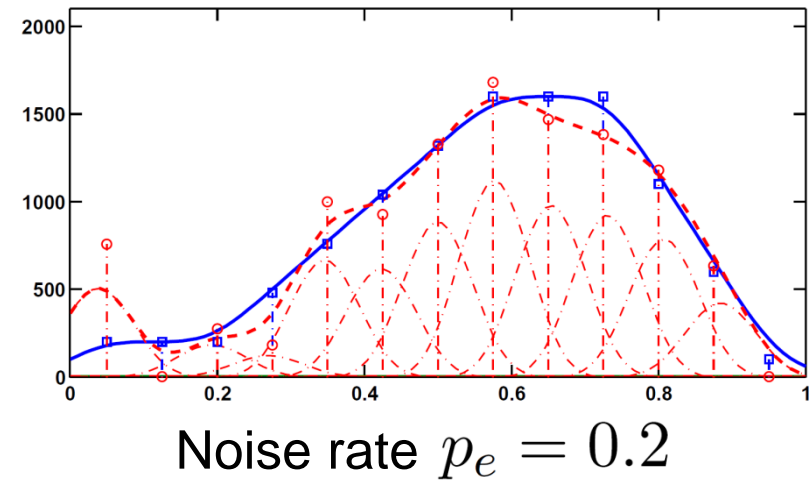
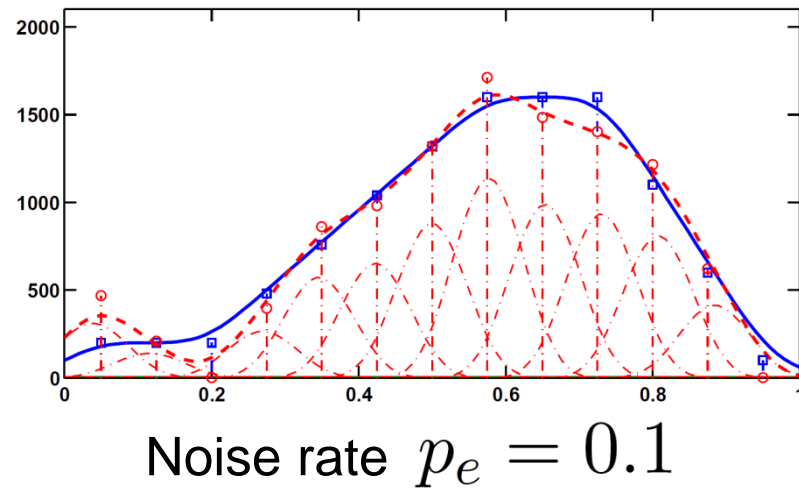
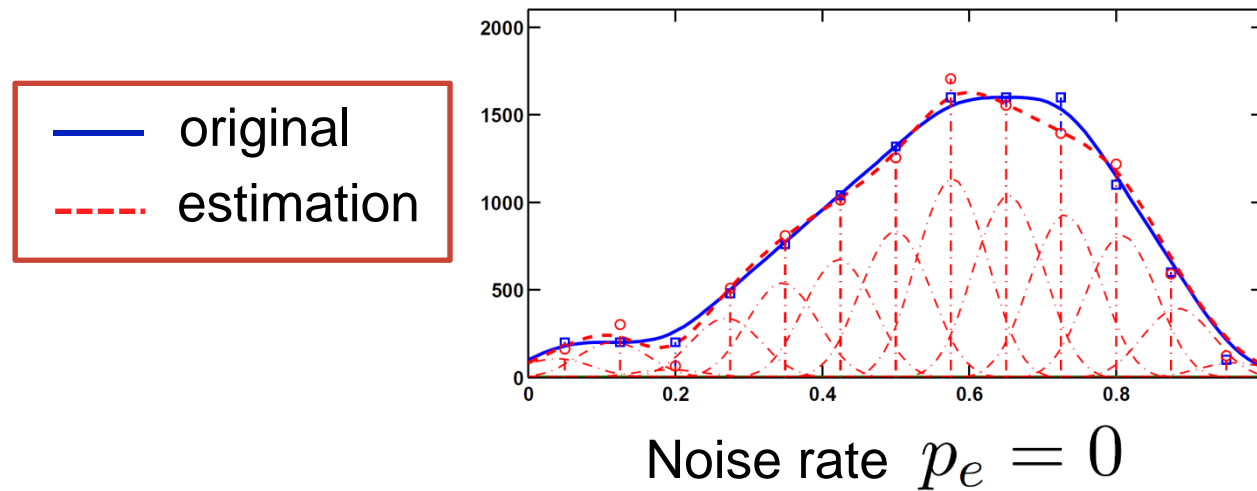
1. Initial estimation, using piecewise-constant assumption
2. Refined estimation, using the iterative algorithm, i.e., Newton's method

Numerical results: 1-D signals



Spatial oversampling $K = 1024$, threshold $q = 1$

Numerical results: 1-D signals



Spatial oversampling $K = 512$, threshold $q = 3$

Numerical results: 2-D images

Threshold: $q=1$, spatial oversampling: 8×8 , temporal oversampling: 128

Original



Noise rate
 $p_e = 0$



Noise rate
 $p_e = 0.1$



Noise rate
 $p_e = 0.2$



Numerical results: 2-D images



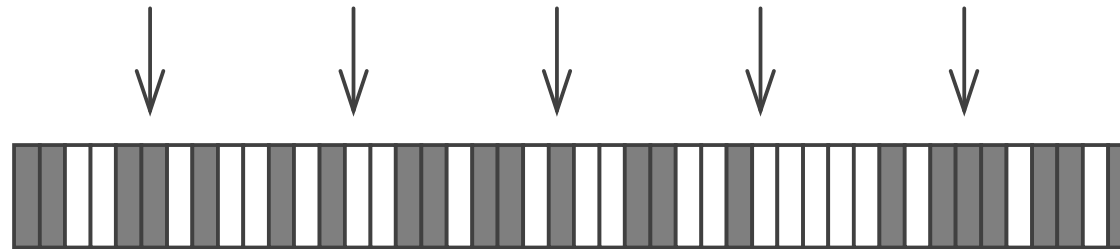
Noise rate $p_e = 0.2$

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The Cramér-Rao lower bound (CRLB)

Using K pixels to estimate a constant light exposure value c



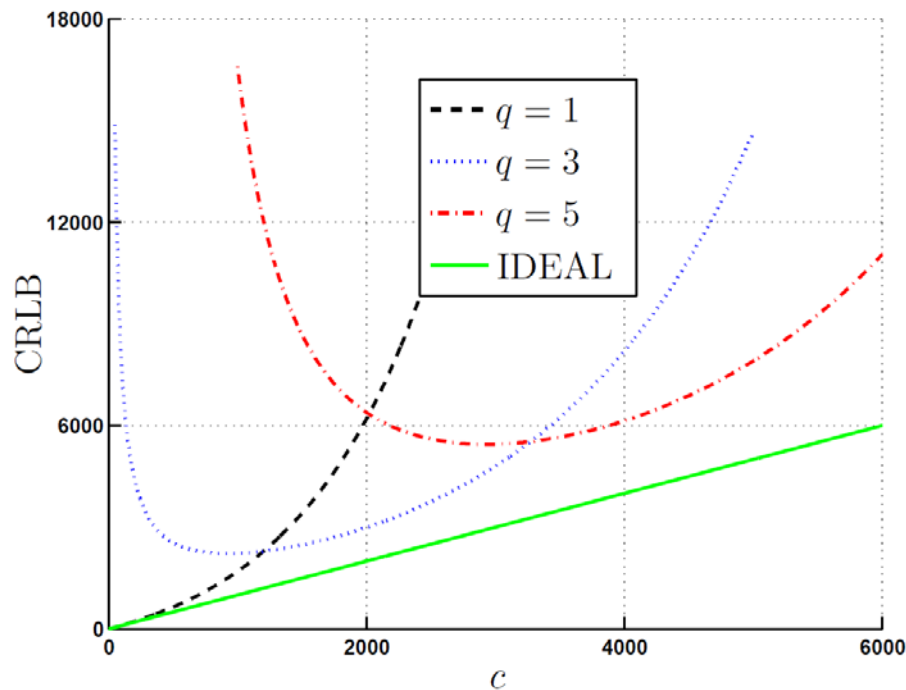
Ideal sensor: $\text{CRLB}_{\text{ideal}} = c$

Binary sensor:

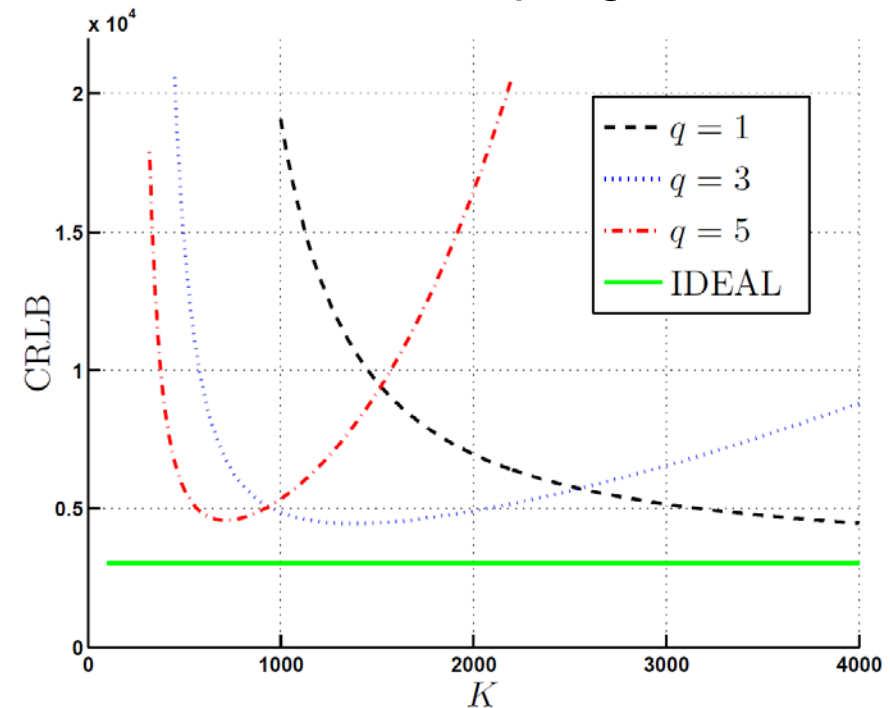
$$\text{CRLB}_{\text{bin}}(K, q) = c \left(\sum_{j=0}^{q-1} \frac{(q-1)!(c/K)^{-j}}{(q-1-j)!} \right) \left(\sum_{j=0}^{\infty} \frac{(q-1)!(c/K)^j}{(q+j)!} \right)$$

The Cramér-Rao lower bound (CRLB)

CRLB vs. light exposure value c



CRLB vs. oversampling factor K



Proposition:

For threshold $q=1$, $\lim_{K \rightarrow \infty} \text{CRLB}_{\text{bin}}(K, q) = \text{CRLB}_{\text{ideal}}$

For $q>1$, $\lim_{K \rightarrow \infty} \text{CRLB}_{\text{bin}}(K, q) / \text{CRLB}_{\text{ideal}} = \infty$

Optimal threshold pattern and reconstruction

2-D sensor with two interleaved thresholds

q_1	q_2	q_1	q_2
q_2	q_1	q_2	q_1
q_1	q_2	q_1	q_2
q_2	q_1	q_2	q_1

Optimal Criterion: Find the minimum average *CRLB*

$$(q_{1,\text{opt}}, q_{2,\text{opt}}) = \arg \min_{1 \leq q_1, q_2 \leq q_{\max}} \int_{c_{\min}}^{c_{\max}} \text{CRLB}_{\text{bin2}}(K/2, K/2, q_1, q_2, c) dc$$

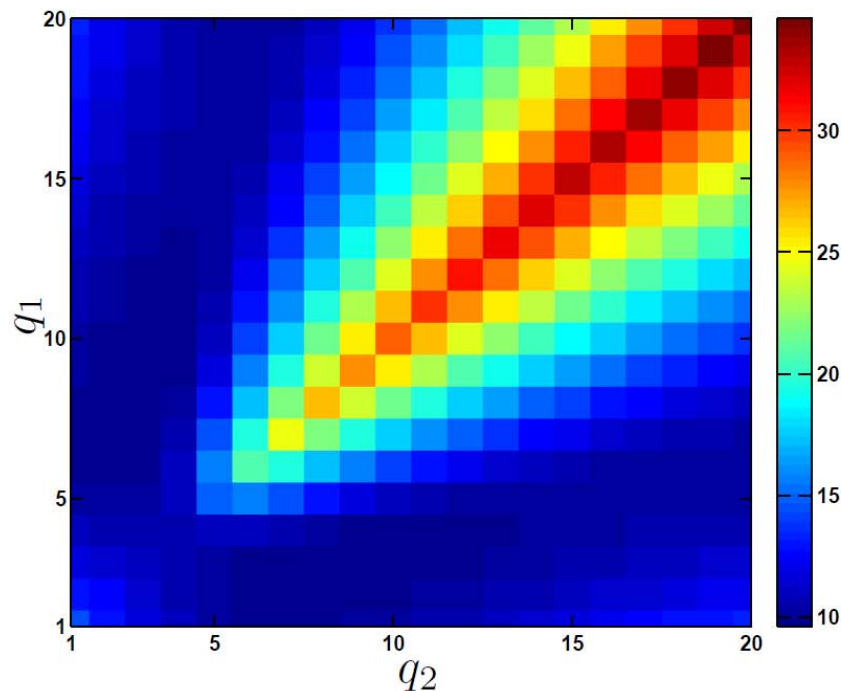
Maximum likelihood estimator

$$\hat{c}_{\text{ML}}(\mathbf{b}) \stackrel{\text{def}}{=} \arg \max_{\mathbf{c} \in [0, S]^N} \mathcal{L}_{\mathbf{b}}(\mathbf{c}) = \arg \max_{\mathbf{c} \in [0, S]^N} \ell_{\mathbf{b}}(\mathbf{c})$$

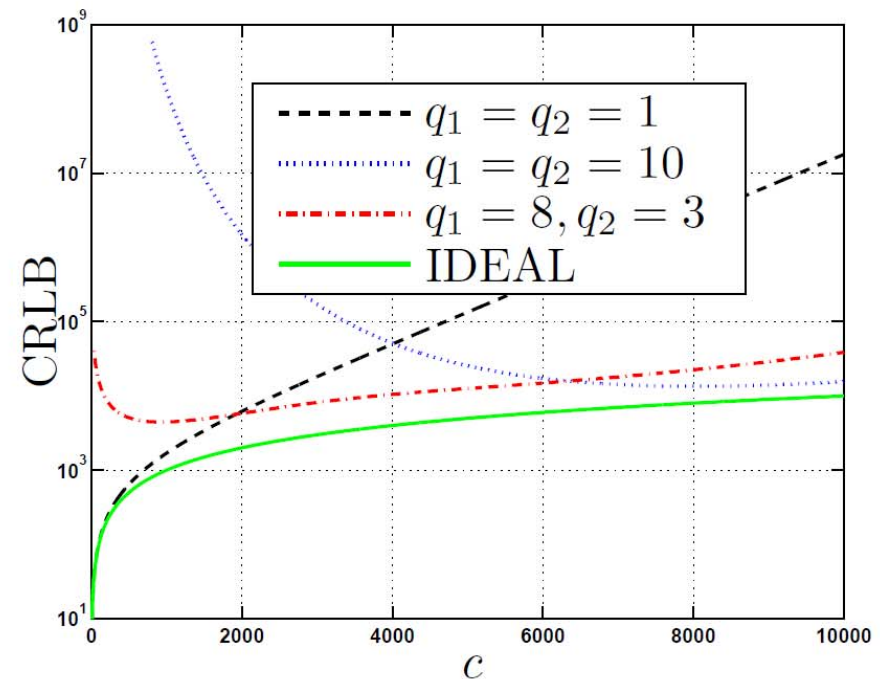
Proposition: The log-likelihood function is **concave**.

Design example

Optimal threshold pattern, when $K = 1024$, $c \in [10, 10^4]$

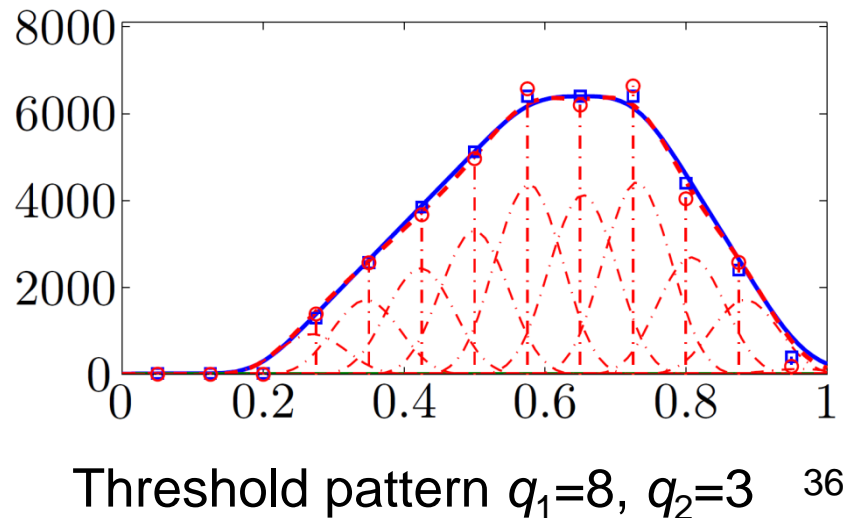
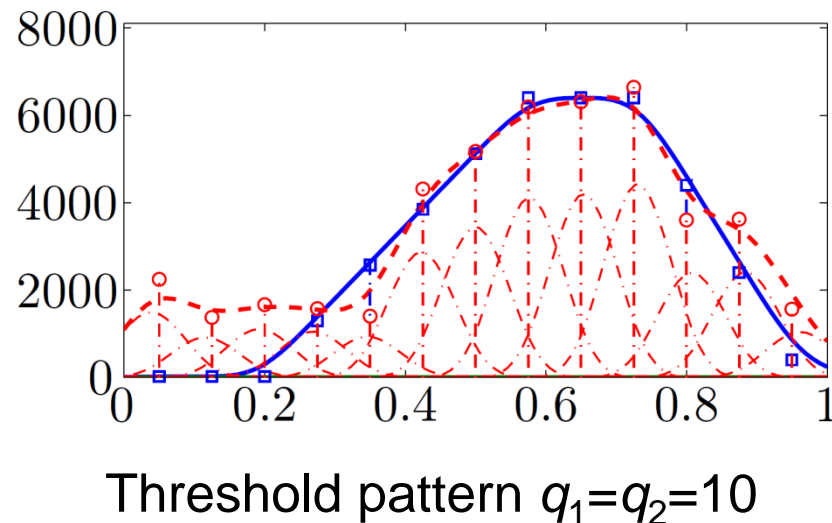
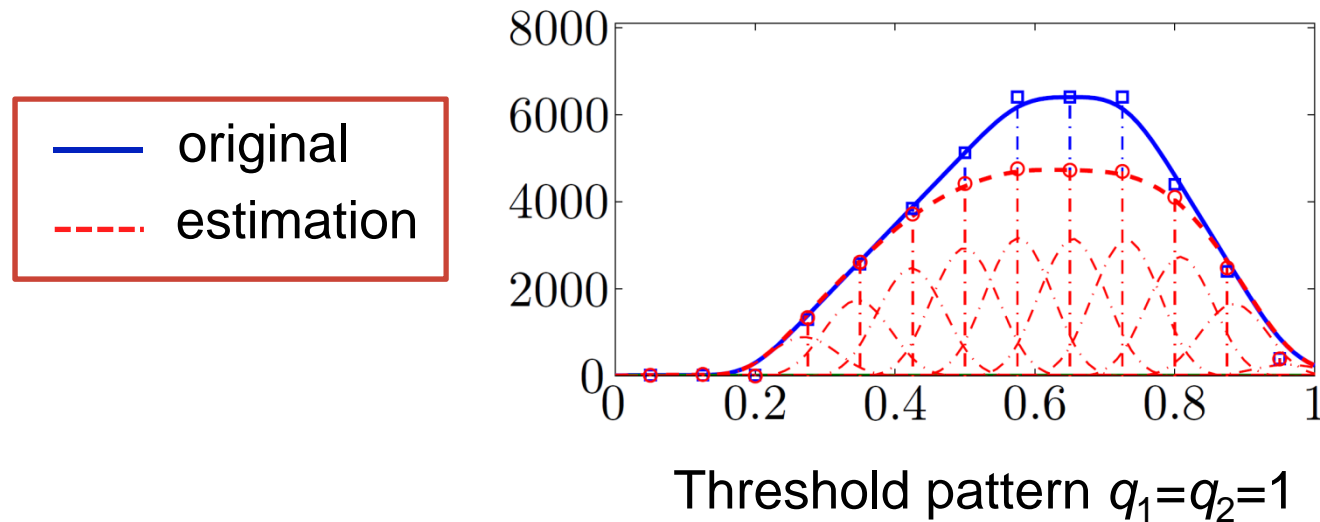


Average $CRLB$ for
different threshold patterns
Optimal pattern $q_1=8$, $q_2=3$



$CRLB$ for different
threshold patterns

Numerical results: 1-D signals



Numerical results – synthetic images

Threshold: $q=1$, spatial oversampling: 8×8 , temporal oversampling: 16

Original



$q_1=1$
 $q_2=1$

$q_1=10$
 $q_2=10$



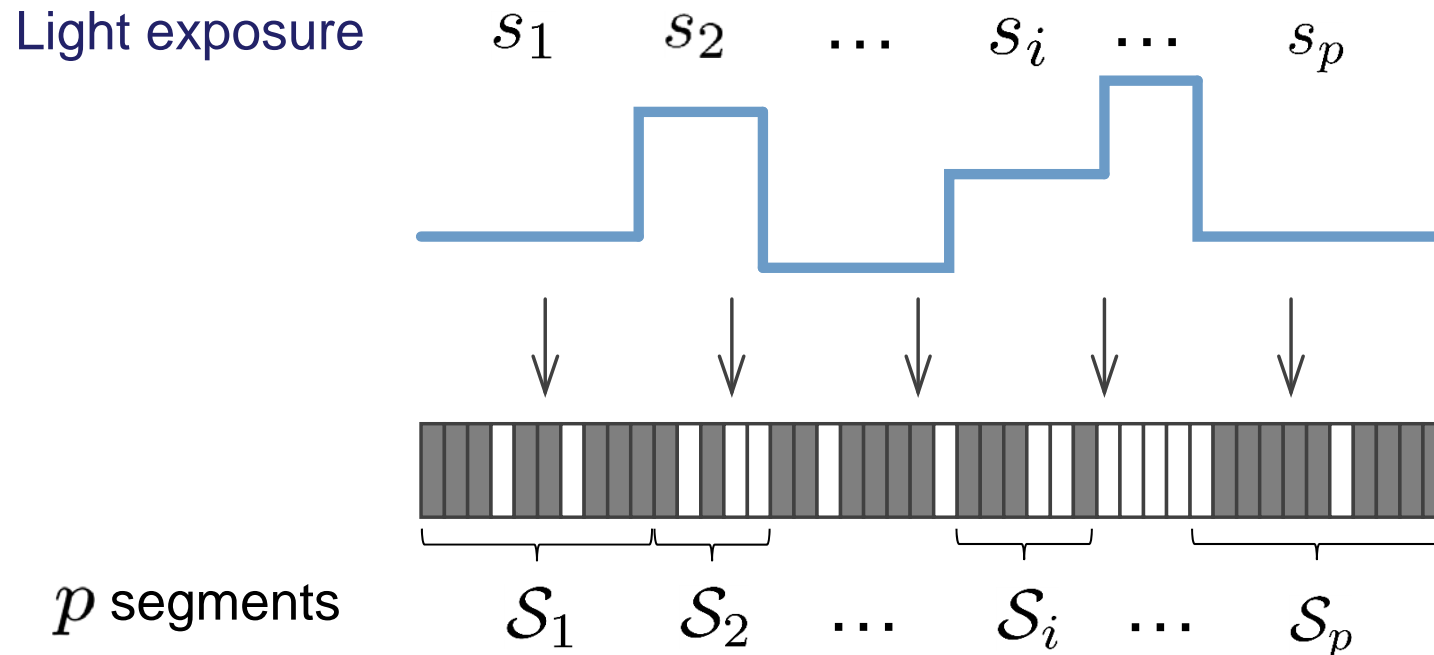
$q_1=8$
 $q_2=3$

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Generalized piecewise-constant model

Estimate the light exposure values $\{s_m\}$ using M binary measurements



Estimate the light exposure values changed to reconstruct

$$\mathcal{P} \stackrel{\text{def}}{=} \{(S_1, s_1), (S_2, s_2), \dots, (S_i, s_i), \dots, (S_p, s_p)\}$$

Reconstruction using MLE (1/2)

Likelihood function

$$\mathcal{L}_b(\mathcal{P}) = \prod_{i=0}^p \mathbb{P}(B_m = b_m, m \in \mathcal{S}_i; (\mathcal{S}_i, s_i)) \theta^{p-1} (1 - \theta)$$

Log-likelihood function

$$\ell_b(\mathcal{P}) \stackrel{\text{def}}{=} \log \mathcal{L}_b(\mathcal{P})$$

Probability for
segment i with light
exposure value s_i

Probability when
there are p
segments

Maximum likelihood estimator

$$\hat{\mathcal{P}} \stackrel{\text{def}}{=} \arg \max_{\mathcal{P}, s_i \in [0, S]} \ell_b(\mathcal{P})$$

Data term

Penalization
term

$$= \arg \max_{\mathcal{P}, s_i \in [0, S]} \sum_{i=1}^p \mathbb{P}(B_m = b_m, m \in \mathcal{S}_i; (\mathcal{S}_i, s_i)) - \gamma p$$

Reconstruction using MLE (2/2)

Iteratively solving two problems

1. Estimate light exposure values

$$\hat{s}_i \stackrel{\text{def}}{=} \arg \max_{s_i \in [0, S]} \mathbb{P}(B_m = b_m, m \in \mathcal{S}_i; (\mathcal{S}_i, s_i))$$

Solution: bisection method

2. Estimate segments

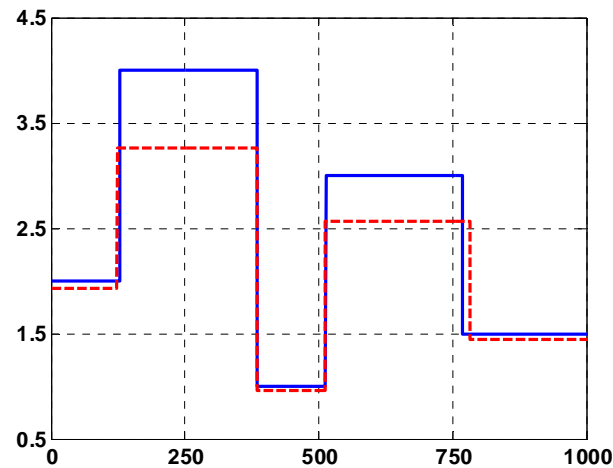
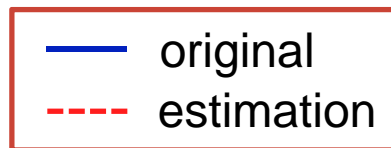
$$\hat{\mathcal{G}} \stackrel{\text{def}}{=} \arg \max_{\mathcal{G}} \mathbb{P}(B_m = b_m, m \in \mathcal{S}_i; (\mathcal{S}_i, \hat{s}_i)) - \gamma p$$

Solution: dynamic programming, greedy algorithm or pruning of binary trees (for 2-D case, quadtrees) .

Segments
are known

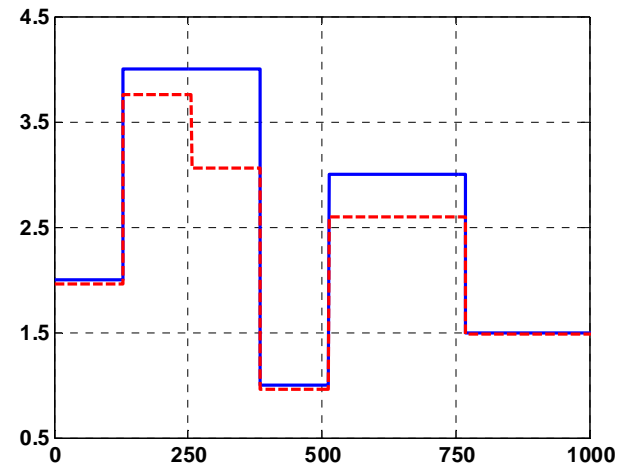
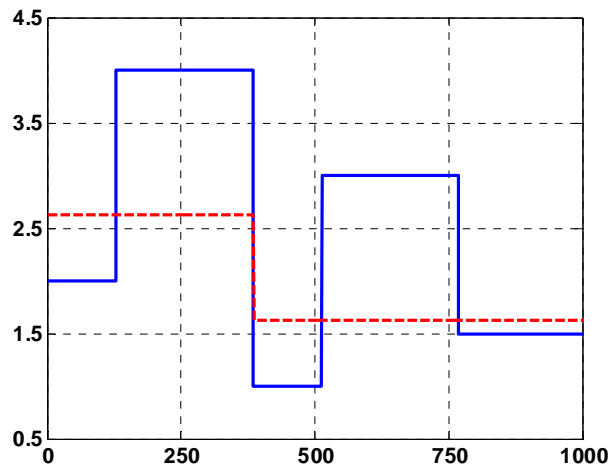
Light exposure
values are known

Numerical results: 1-D signals



Dynamic programming

Greedy



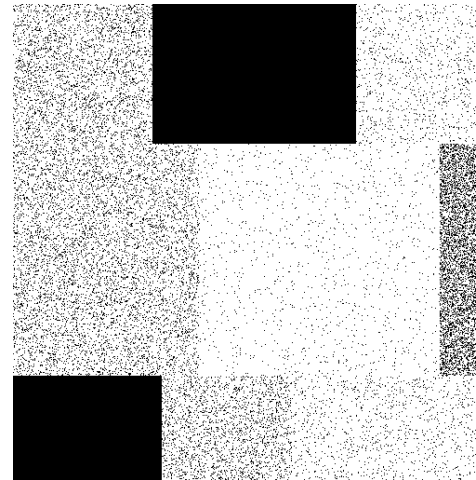
Pruning binary tree

Numerical results: synthetic images

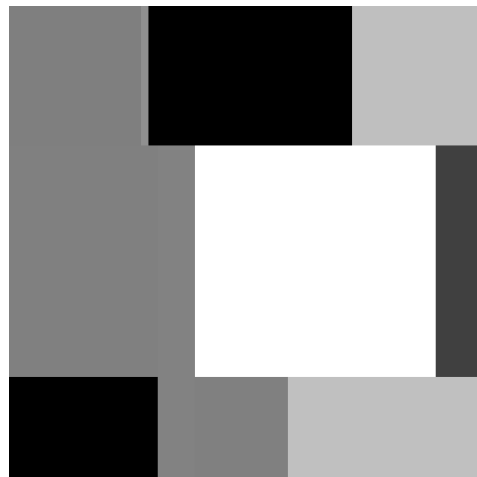
Original



Binary image



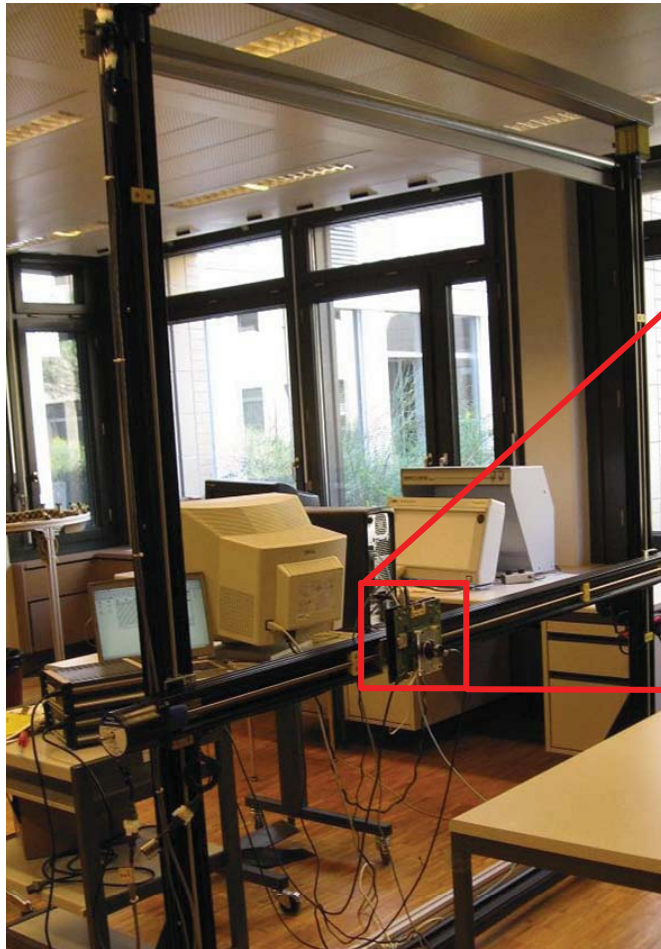
Greedy



Pruning
Quadrees



Experimental results: real images (1/2)



SPAD camera
Resolution: 32×32

Experimental results: real images (2/2)



Binary image, 1024×1024



128×128

Greedy



128×128

Pruning
Quadtrees

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Conclusions

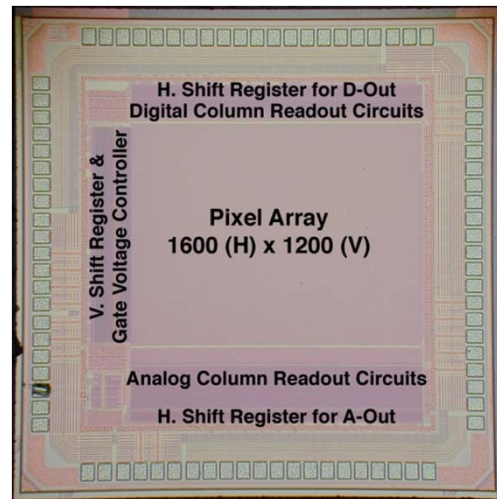
- Oversampled binary imaging
 - Diffraction limit and spatial oversampling
 - Binary pixel
 - Log-likelihood function is concave
- Noise performance
 - Robust to noise for large light intensity
 - Constant, log-likelihood function,
 - concave ($q=1$)
 - strictly pseudoconcave ($q>1$)

Conclusions

- Threshold and optimal pattern design
 - Asymptotic behavior
 - Large threshold strong light intensity, small threshold low light intensity
 - Optimal threshold pattern
 - Log-likelihood function is concave
- Generalized piecewise-constant model
 - Maximum likelihood estimator
 - Iteratively solving two problems

Future Research

- Sensor design



90nm technology

Pixel size: $0.75\mu\text{m} \times 0.75\mu\text{m}$

Chip size: $2\text{mm} \times 2\text{mm}$

Resolution: 1600×1200

Designed by Prof. Charbon's team

- Super resolution for binary images
- Color sensor

References

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- **F. Yang**, Y. Lu, L. Sbaiz and M. Vetterli, Bits from photons: Oversampled image acquisition using binary Poisson Statistics, *IEEE Transactions on Image Processing*, 2012, accepted



<http://panorama.epfl.ch>

Questions?